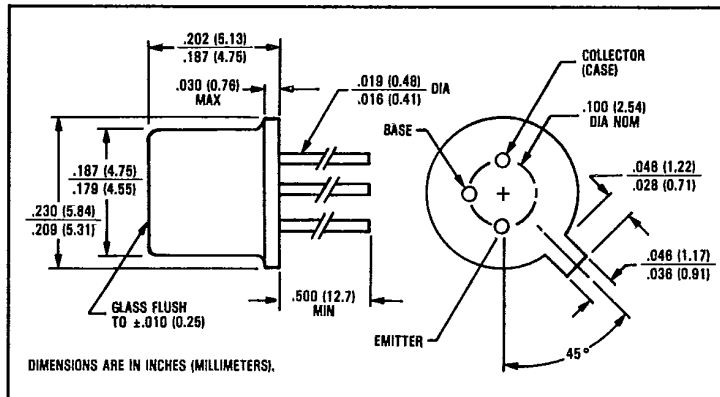
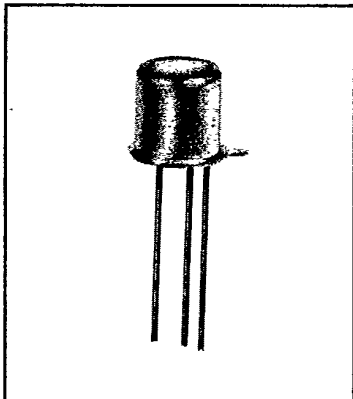


NPN Silicon Phototransistors

Types OP841W, OP842W, OP843W, OP844W, OP845W



Features

- Collector currents specified as minimums
- Flat lensed for wide acceptance angle
- TO-18 hermetically sealed package

Description

The OP841W through OP845W each consist of an NPN silicon phototransistor mounted in a flat lensed, hermetically sealed, TO-18 package. The flat lens allows an acceptance half angle of 40° measured from the optical axis to the half power point. The base lead is bonded to enable conventional transistor biasing. Except for minor differences in collector current ranges and minimum range binning only, this series is identical to the OP800W series and is mechanically and spectrally matched to the OP130W and OP231W series of infrared emitting diodes.

Absolute Maximum Ratings ($T_A = 25^\circ\text{C}$ unless otherwise noted)

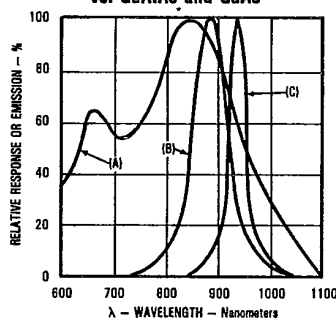
Collector-Base Voltage	30 V
Collector-Emitter Voltage	30 V
Emitter-Base Voltage	5.0 V
Emitter-Collector Voltage	5.0 V
Continuous Collector Current	50 mA
Storage Temperature Range	-65°C to +150°C
Operating Temperature Range	-65°C to +125°C
Lead Soldering Temperature (1/16 inch [1.6 mm] from case for 5 sec. with soldering iron ⁽¹⁾)	240°C
Power Dissipation	250 mW ⁽²⁾

Notes:

- (1) RMA flux is recommended. Duration can be extended to 10 sec. max. when wave soldering.
- (2) Derate linearly 2.5 mW/°C above 25°C.
- (3) Junction temperature maintained at 25°C.
- (4) Light source is an unfiltered tungsten bulb operating at $CT = 2870^\circ\text{K}$ or equivalent infrared source.

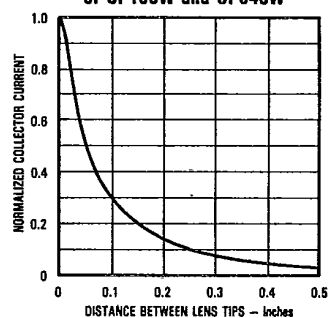
Typical Performance Curves

Spectral Response of OP841W-OP845W
vs. GaAlAs and GaAs



Test Conditions (LED): $T_A = T_J = 25^\circ\text{C}$, $I_C = 100\text{ mA}$,
 $OC = 0.1\%$, $PW = 100\text{ }\mu\text{s}$
Peak Wavelength - λ_p : (A) XSTR - $850 \pm 30\text{ nm}$, (B) LED
GaAlAs - $875 \pm 20\text{ nm}$, (C) LED GaAs - $930 \pm 15\text{ nm}$

Coupling Characteristics
of OP130W and OP840W



Types OP841W, OP842W, OP843W, OP844W, OP845W

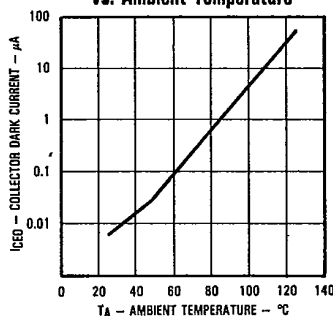
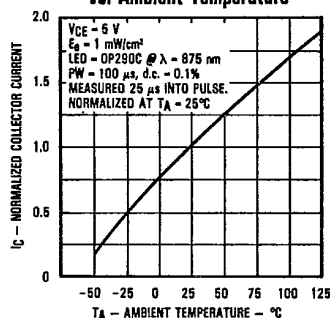
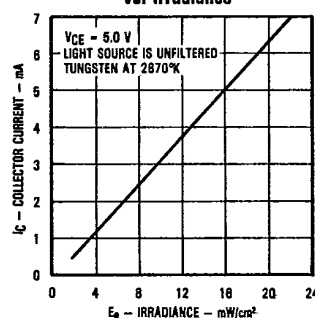
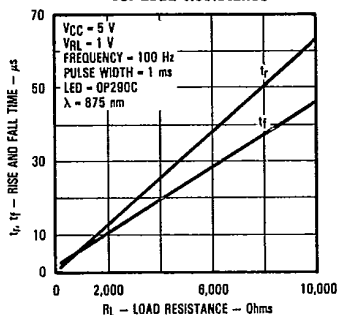
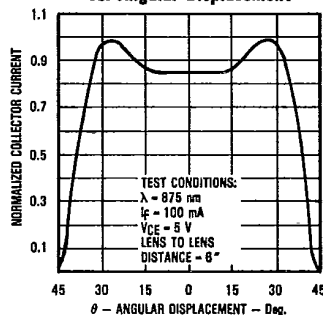
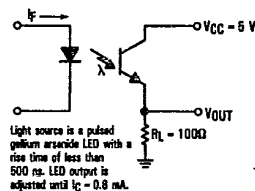
T-41-6)

Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$I_{C(ON)}^{(3)}$	On-State Collector Current	OP841W 0.30 OP842W 1.00 OP843W 1.50 OP844W 2.0 OP845W 2.5			mA	$V_{CE} = 5.0\text{ V}$, $E_g = 5.0\text{ mW/cm}^2$ ⁽⁴⁾ $V_{CE} = 5.0\text{ V}$, $E_g = 5.0\text{ mW/cm}^2$ ⁽⁴⁾ $V_{CE} = 5.0\text{ V}$, $E_g = 5.0\text{ mW/cm}^2$ ⁽⁴⁾ $V_{CE} = 5.0\text{ V}$, $E_g = 5.0\text{ mW/cm}^2$ ⁽⁴⁾ $V_{CE} = 5.0\text{ V}$, $E_g = 5.0\text{ mW/cm}^2$ ⁽⁴⁾
I_{CEO}	Collector Dark Current			100	nA	$V_{CE} = 10.0\text{ V}$, $E_g = 0$
$V_{(BR)CEO}$	Collector-Emitter Breakdown Voltage	30			V	$I_C = 100\text{ }\mu\text{A}$
$V_{(BR)ECO}$	Emitter-Collector Breakdown Voltage	5.0			V	$I_E = 100\text{ }\mu\text{A}$
$V_{CE(SAT)}^{(3)}$	Collector-Emitter Saturation Voltage		0.40		V	$I_C = 0.40\text{ mA}$, $E_g = 5.0\text{ mW/cm}^2$ ⁽⁴⁾
t_r	Rise Time		2.0		μs	$V_{CC} = 5.0\text{ V}$, $I_C = 0.80\text{ mA}$
t_f	Fall Time		2.0		μs	$R_L = 100\Omega$, See Test Circuit

D

Typical Performance Curves

Collector Dark Current
vs. Ambient TemperatureNormalized Collector Current
vs. Ambient TemperatureCollector Current
vs. IrradianceRise and Fall Time
vs. Load ResistanceNormalized Collector Current
vs. Angular DisplacementSwitching Time
Test Circuit

TRW reserves the right to make changes at any time in order to improve design and to supply the best product possible.

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